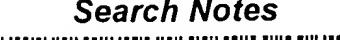


<b>Search Notes</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/724,066	YANG ET AL.
	Examiner Khai M. Nguyen	Art Unit 2617

<b>INTERFERENCE SEARCHED</b>			
Class	Subclass	Date	Examiner